

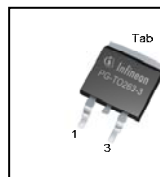
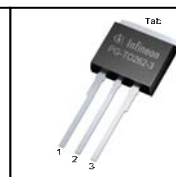
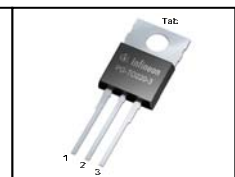
**OptiMOS® -T2 Power-Transistor**

**Features**

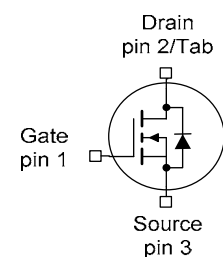
- N-channel - Enhancement mode
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

**Product Summary**

|                                |     |    |
|--------------------------------|-----|----|
| $V_{DS}$                       | 60  | V  |
| $R_{DS(on),max}$ (SMD version) | 2.1 | mΩ |
| $I_D$                          | 120 | A  |

**PG-TO263-3-2**

**PG-TO262-3-1**

**PG-TO220-3-1**


| Type           | Package      | Marking |
|----------------|--------------|---------|
| IPB120N06S4-H1 | PG-TO263-3-2 | 4N06H1  |
| IPI120N06S4-H1 | PG-TO262-3-1 | 4N06H1  |
| IPP120N06S4-H1 | PG-TO220-3-1 | 4N06H1  |


**Maximum ratings, at  $T_j=25^\circ\text{C}$ , unless otherwise specified**

| Parameter                                    | Symbol            | Conditions                                         | Value        | Unit |
|----------------------------------------------|-------------------|----------------------------------------------------|--------------|------|
| Continuous drain current <sup>1)</sup>       | $I_D$             | $T_C=25^\circ\text{C}$ , $V_{GS}=10\text{V}$       | 120          | A    |
|                                              |                   | $T_C=100^\circ\text{C}$ , $V_{GS}=10\text{V}^{2)}$ | 120          |      |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$     | $T_C=25^\circ\text{C}$                             | 480          |      |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$          | $I_D=60\text{A}$                                   | 1060         | mJ   |
| Avalanche current, single pulse              | $I_{AS}$          | -                                                  | 120          | A    |
| Gate source voltage                          | $V_{GS}$          | -                                                  | ±20          | V    |
| Power dissipation                            | $P_{tot}$         | $T_C=25^\circ\text{C}$                             | 250          | W    |
| Operating and storage temperature            | $T_j$ , $T_{stg}$ | -                                                  | -55 ... +175 | °C   |
| IEC climatic category; DIN IEC 68-1          |                   | -                                                  | 55/175/56    |      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Thermal characteristics<sup>2)</sup>

|                                                |            |                                              |   |   |      |     |
|------------------------------------------------|------------|----------------------------------------------|---|---|------|-----|
| Thermal resistance, junction - case            | $R_{thJC}$ | -                                            | - | - | 0.60 | K/W |
| Thermal resistance, junction - ambient, leaded | $R_{thJA}$ | -                                            | - | - | 62   |     |
| SMD version, device on PCB                     | $R_{thJA}$ | minimal footprint                            | - | - | 62   |     |
|                                                |            | 6 cm <sup>2</sup> cooling area <sup>3)</sup> | - | - | 40   |     |

### Electrical characteristics, at $T_j=25^\circ\text{C}$ , unless otherwise specified

#### Static characteristics

|                                  |               |                                                     |     |      |     |            |
|----------------------------------|---------------|-----------------------------------------------------|-----|------|-----|------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0V, I_D=1mA$                                | 60  | -    | -   | V          |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}, I_D=200\mu A$                       | 2.0 | 3.0  | 4.0 |            |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=60V, V_{GS}=0V, T_j=25^\circ\text{C}$       | -   | 0.03 | 1   | $\mu A$    |
|                                  |               | $V_{DS}=60V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$ | -   | 10   | 200 |            |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20V, V_{DS}=0V$                             | -   | -    | 100 | nA         |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10V, I_D=100A$                              | -   | 2.1  | 2.4 | m $\Omega$ |
|                                  |               | $V_{GS}=10V, I_D=100A, \text{SMD version}$          | -   | 1.8  | 2.1 |            |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Dynamic characteristics<sup>2)</sup>

|                              |              |                                                        |   |       |       |    |
|------------------------------|--------------|--------------------------------------------------------|---|-------|-------|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0V, V_{DS}=25V,$<br>$f=1MHz$                   | - | 16840 | 21900 | pF |
| Output capacitance           | $C_{oss}$    |                                                        | - | 4120  | 5360  |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                        | - | 160   | 320   |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=30V, V_{GS}=10V,$<br>$I_D=120A, R_G=3.5\Omega$ | - | 30    | -     | ns |
| Rise time                    | $t_r$        |                                                        | - | 5     | -     |    |
| Turn-off delay time          | $t_{d(off)}$ |                                                        | - | 60    | -     |    |
| Fall time                    | $t_f$        |                                                        | - | 15    | -     |    |

### Gate Charge Characteristics<sup>2)</sup>

|                       |               |                                                       |   |      |     |    |
|-----------------------|---------------|-------------------------------------------------------|---|------|-----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=48V, I_D=120A,$<br>$V_{GS}=0 \text{ to } 10V$ | - | 84   | 110 | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                       | - | 22.5 | 45  |    |
| Gate charge total     | $Q_g$         |                                                       | - | 208  | 270 |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                       | - | 5.0  | -   | V  |

### Reverse Diode

|                                                |               |                                              |     |      |     |    |
|------------------------------------------------|---------------|----------------------------------------------|-----|------|-----|----|
| Diode continuous forward current <sup>2)</sup> | $I_S$         | $T_C=25^\circ C$                             | -   | -    | 120 | A  |
| Diode pulse current <sup>2)</sup>              | $I_{S,pulse}$ |                                              | -   | -    | 480 |    |
| Diode forward voltage                          | $V_{SD}$      | $V_{GS}=0V, I_F=100A,$<br>$T_j=25^\circ C$   | 0.6 | 0.95 | 1.3 | V  |
| Reverse recovery time <sup>2)</sup>            | $t_{rr}$      | $V_R=30V, I_F=120A,$<br>$di_F/dt=100A/\mu s$ | -   | 60   | -   | ns |
| Reverse recovery charge <sup>2)</sup>          | $Q_{rr}$      |                                              | -   | 90   | -   |    |

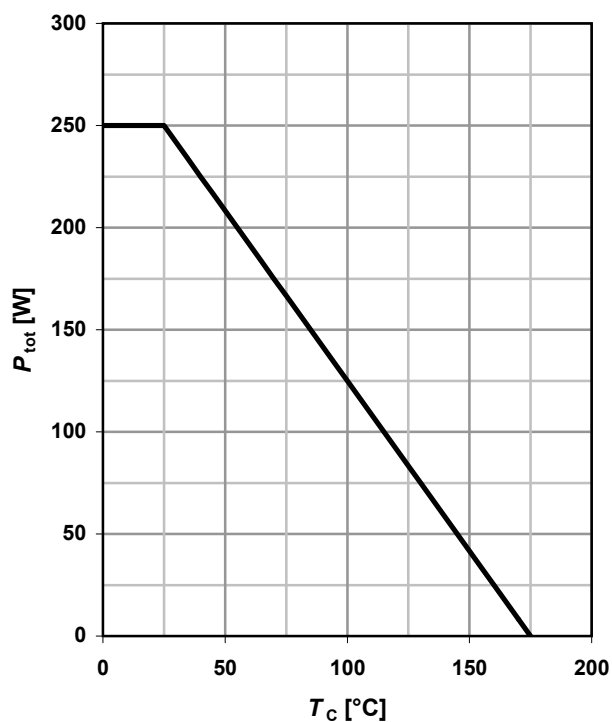
<sup>1)</sup> Current is limited by bondwire; with an  $R_{thJC} = 0.6K/W$  the chip is able to carry 261A at 25°C.

<sup>2)</sup> Specified by design. Not subject to production test.

<sup>3)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

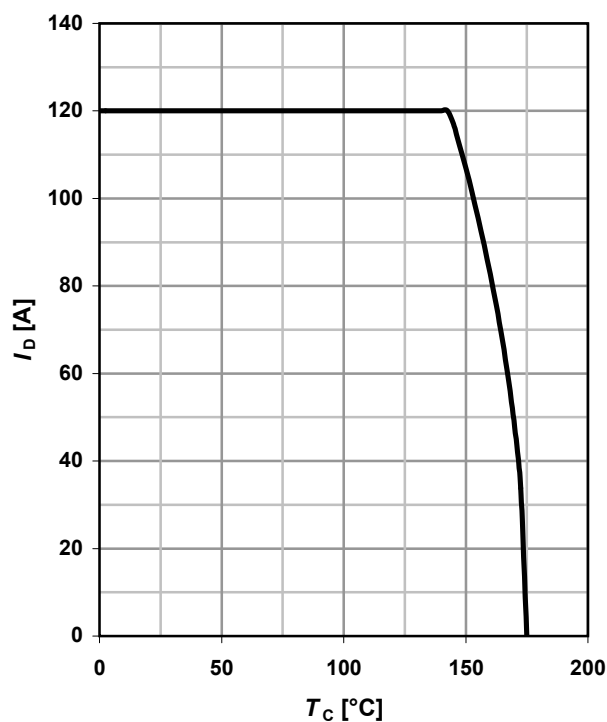
## 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



## 2 Drain current

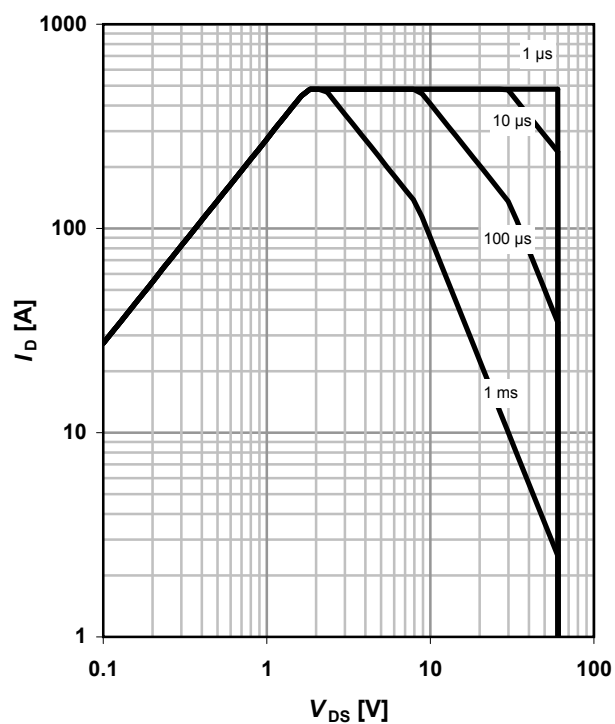
$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}; \text{SMD}$$



## 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25 \text{ °C}; D = 0; \text{SMD}$$

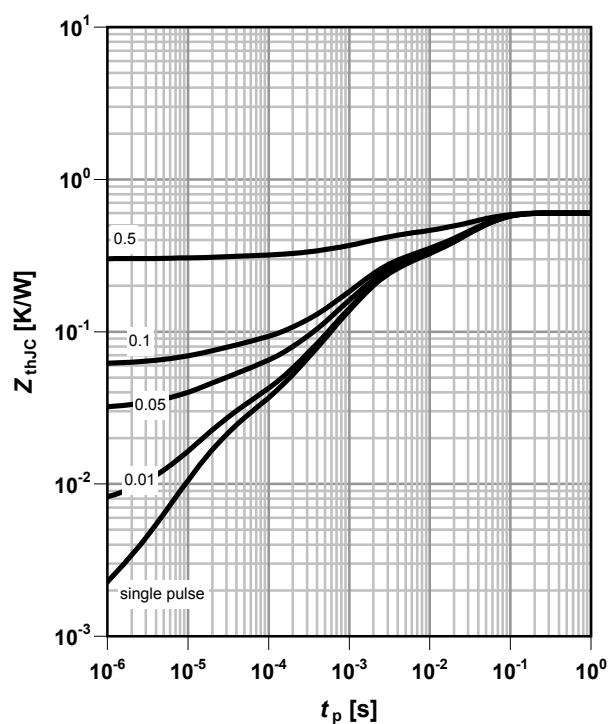
parameter:  $t_p$



## 4 Max. transient thermal impedance

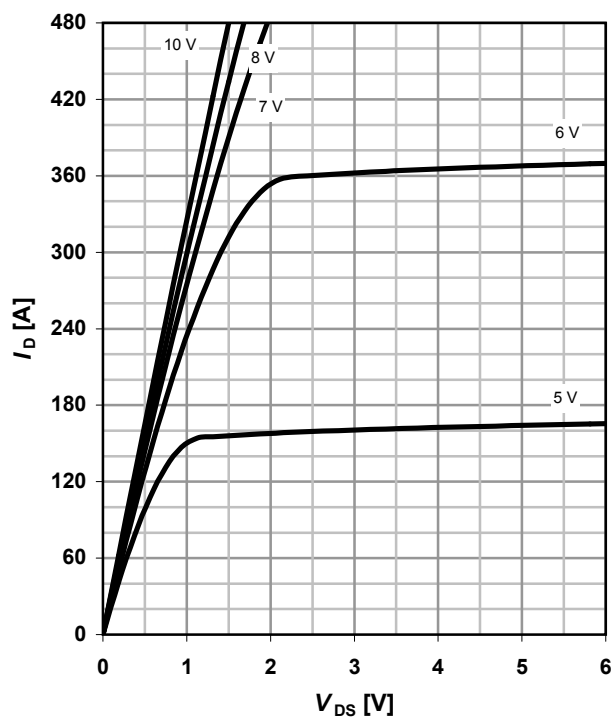
$$Z_{\text{thJC}} = f(t_p)$$

parameter:  $D = t_p/T$



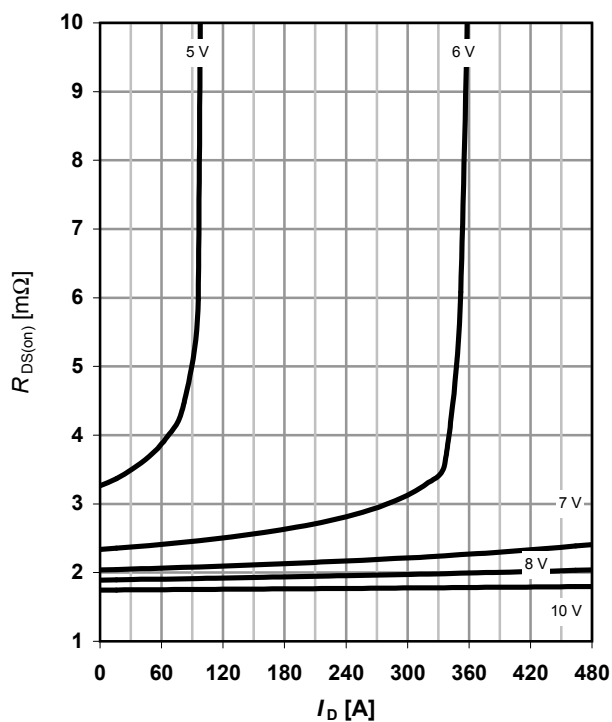
## 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{SMD}$ 

parameter:  $V_{GS}$ 


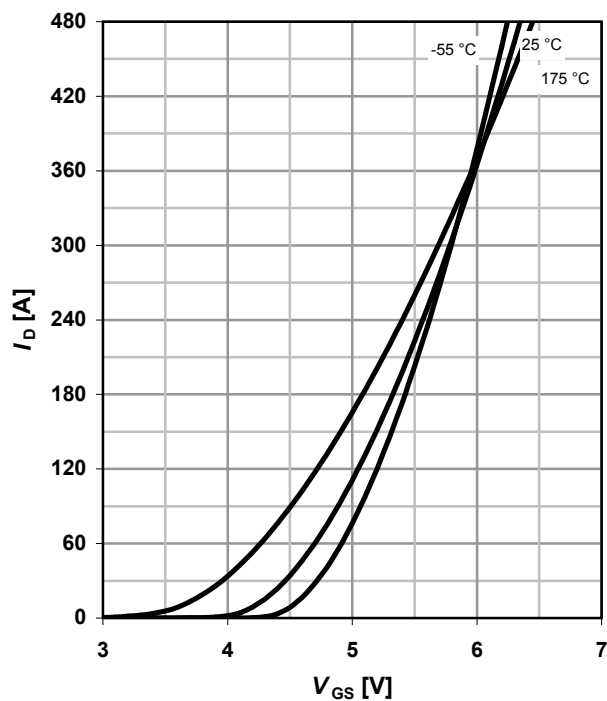
## 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{SMD}$ 

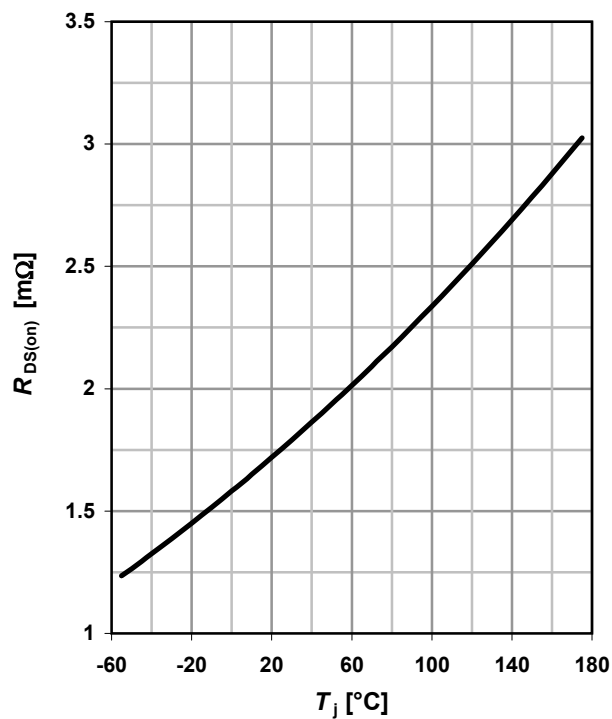
parameter:  $V_{GS}$ 


## 7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6\text{ V}$ 

parameter:  $T_j$ 


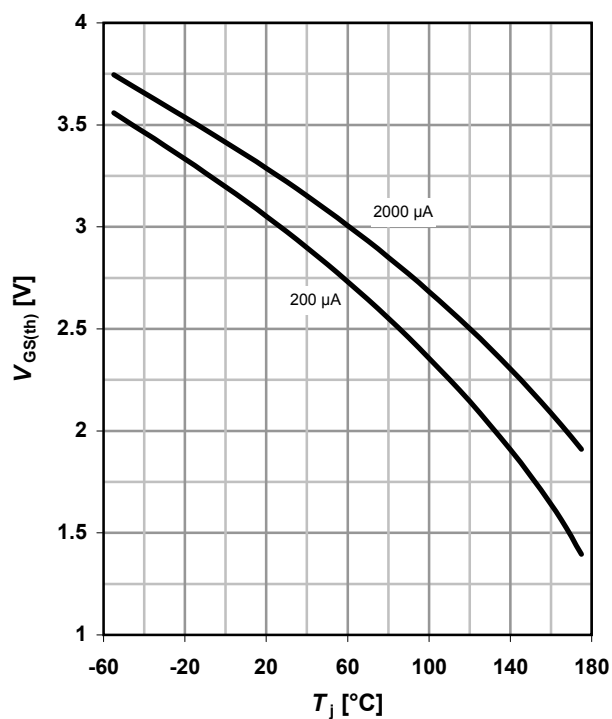
## 8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 100\text{ A}; V_{GS} = 10\text{ V}; \text{SMD}$ 


## 9 Typ. gate threshold voltage

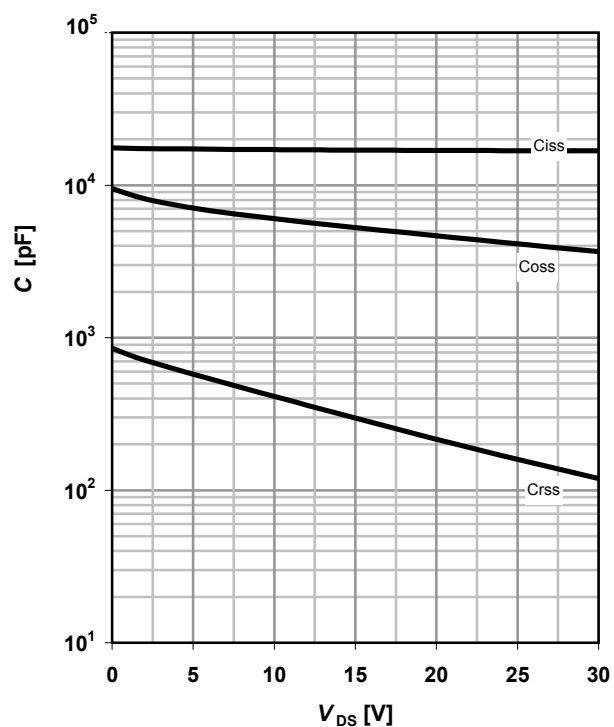
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter:  $I_D$



## 10 Typ. capacitances

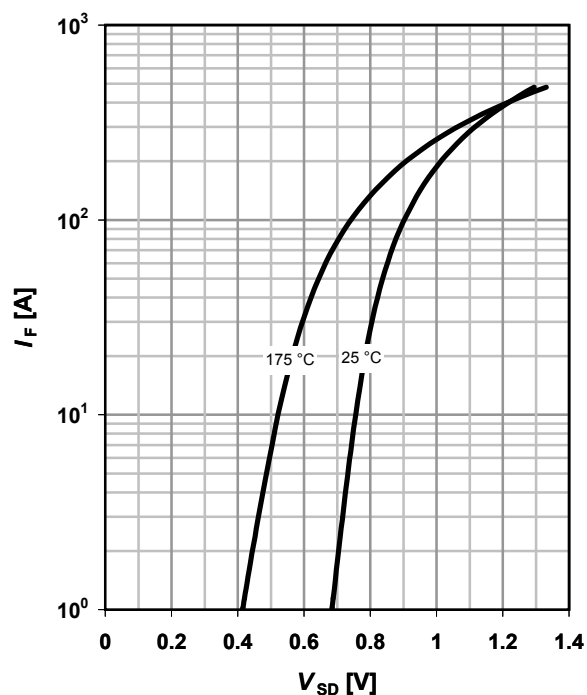
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



## 11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

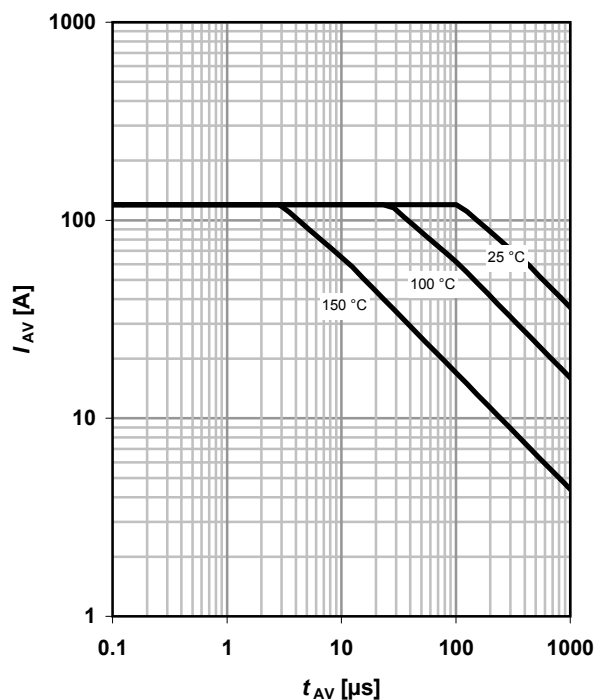
parameter:  $T_j$



## 12 Avalanche characteristics

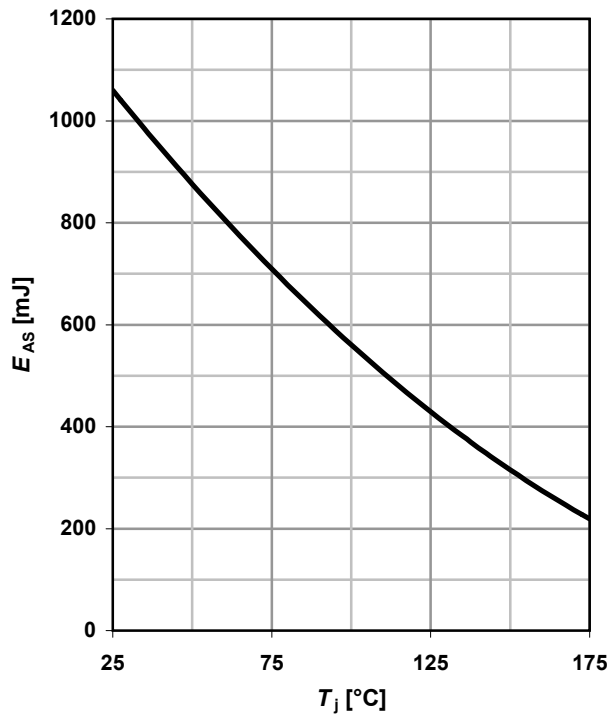
$$I_{AS} = f(t_{AV})$$

parameter:  $T_{j(start)}$



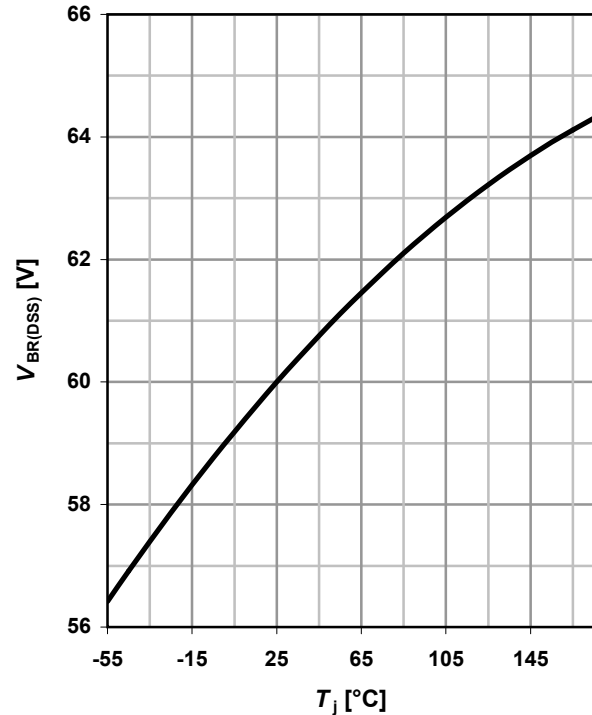
### 13 Avalanche energy

$$E_{AS} = f(T_j); I_D = 60 \text{ A}$$



### 14 Drain-source breakdown voltage

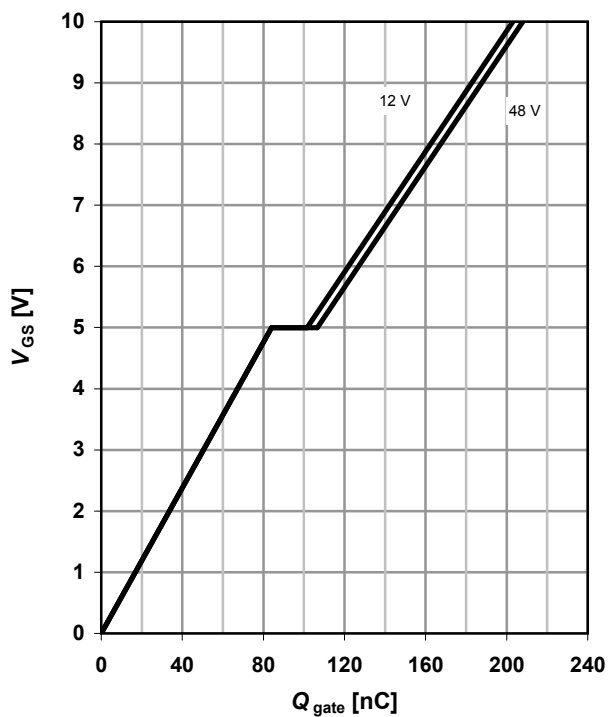
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



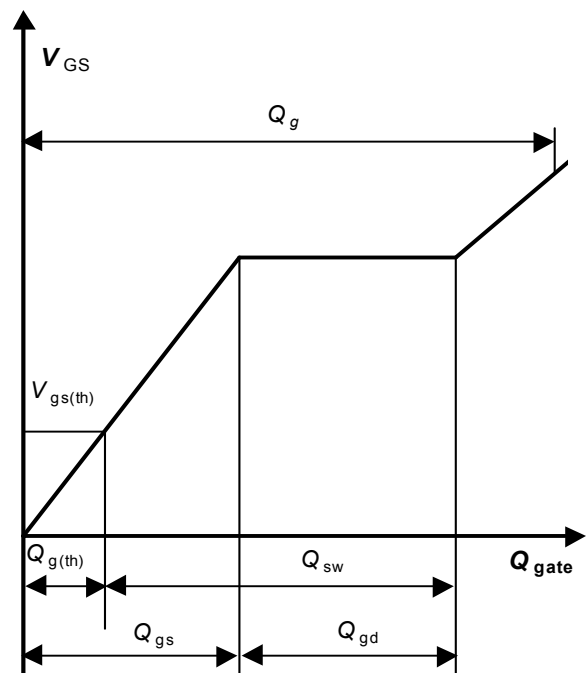
### 15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 120 \text{ A pulsed}$$

parameter:  $V_{DD}$



### 16 Gate charge waveforms



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## Revision History

| Version      | Date       | Changes          |
|--------------|------------|------------------|
| Revision 1.0 | 23.03.2009 | Final data sheet |